IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Examiner: Michael J. Vanchy Jr.,

Yukio Kuramasu Art Group: 262

Application No.: 10/560,270 Confirmation No.: 3356

Filed: January 5, 2006

For: IMPURITY MEASURING METHOD

AND DEVICE

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

AMENDMENT AND RESPONSE TO OFFICE ACTION

Sir:

In response to the Office Action mailed June 24, 2008 regarding the above-referenced application, Applicants respectfully request entry of the amendments set forth below in consideration of the remarks that follow.